

Notice of References Cited	Application/Control No. 10/661,504		Applicant(s)/Patent Under Reexamination SUGIYAMA, TAKAAKI	
	Examiner Qing Chen		Art Unit 2191	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,481,601	01-1996	Nazif et al.	379/201.03
*	B	US-5,907,607	05-1999	Waters et al.	379/201.03
*	C	US-5,978,583	11-1999	Ekanadham et al.	717/106
*	D	US-6,038,563	03-2000	Bapat et al.	707/10
*	E	US-6,173,437 B1	01-2001	Polcyn, Michael J.	717/100
*	F	US-6,363,411 B1	03-2002	Dugan et al.	709/202
*	G	US-6,594,355 B1	07-2003	Deo et al.	379/219
*	H	US-6,728,947 B1	04-2004	Bengston, Michael B.	717/103
*	I	US-6,799,314 B2	09-2004	Beniyama et al.	717/100
*	J	US-6,851,115 B1	02-2005	Cheyser et al.	719/317
*	K	US-6,892,228 B1	05-2005	Penders, Alain	709/219
*	L	US-6,895,573 B2	05-2005	N.o slashed.rgaard et al.	717/100
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.